## 5. RF EXPOSURE EVALUATION

## 5.1 Applicable Standard

According to KDB447498 D01 General RF Exposure Guidance v06: 4.3. General SAR test exclusion guidance

Report No.: 2403S73382E-RF-00G

- c) For frequencies below 100 MHz, the following may be considered for SAR test exclusion (also illustrated in Appendix C):
- 1) For test separation distances > 50 mm and < 200 mm, the power threshold at the corresponding test separation distance at 100 MHz in step b) is multiplied by  $[1 + \log(100/f_{\text{(MHz)}})]$
- 2) For test separation distances  $\leq$  50 mm, the power threshold determined by the equation in c) 1) for 50 mm and 100 MHz is multiplied by  $\frac{1}{2}$
- 3) SAR measurement procedures are not established below 100 MHz

## **5.2Measurement Result:**

For NFC, the power of EUT: E Field@3m is 63.19dBuV/m =-32.01 dBm(0.001mW) Note: E[dB $\mu$ V/m] = EIRP[dBm] + 95.2 for d = 3 m.

SAR test exclusion threshold for NFC(13.56MHz) separation distance < 50mm

 $=[474*(1 + \log(100/f_{(MHz)}))]/2$ 

 $=443 \mathrm{mW}$ 

>0.001mW

**Result: Compliant.**